ne<mark>x</mark>peria

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In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

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Should be replaced with:

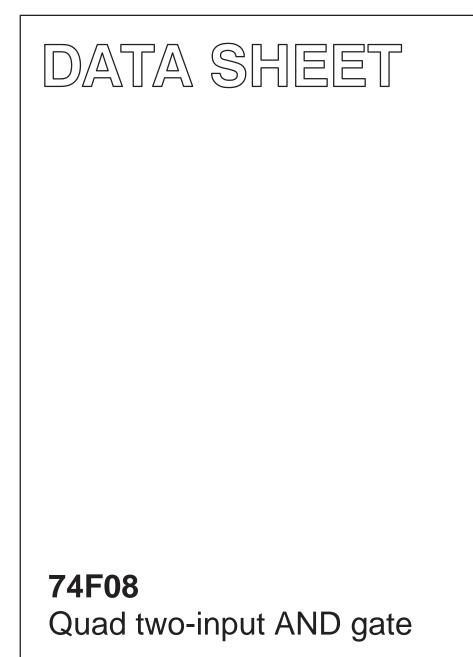
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If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

INTEGRATED CIRCUITS



Product specification

1995 Apr 19

IC15 Data Handbook

Philips Semiconductors



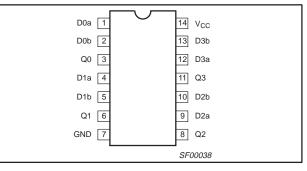


74F08

74F08 Available for industrial range (-40°C to +85°C)

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F08	4.1ns	7.1mA

PIN CONFIGURATION



ORDERING INFORMATION

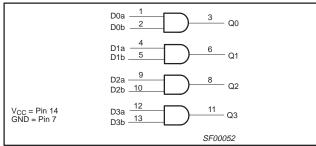
DESCRIPTION	COMMERCIAL RANGE V _{CC} = 5.0V ±10%, T _{amb} = 0°C to +70°C	INDUSTRIAL RANGE V _{CC} = 5.0V \pm 10%, T _{amb} = -40°C to +85°C	PKG DWG #
14-pin plastic DIP	N74F08N	174F08N	SOT27-1
14-pin plastic SO	N74F08D	I74F08D	SOT108-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

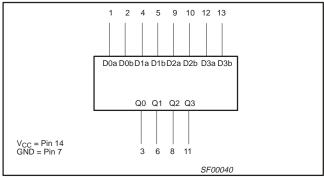
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
Dna, Dnb	Data inputs	1.0/1.0	20µA/0.6mA
Qn	Data output	50/33	1.0mA/20mA

NOTE: One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC DIAGRAM



LOGIC SYMBOL



FUNCTION TABLE

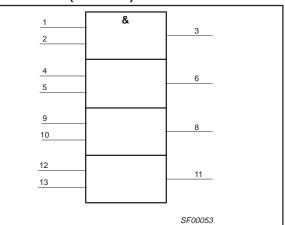
INP	UTS	OUTPUT
Dna	Dnb	Qn
L	L	L
L	Н	L
Н	L	L
Н	Н	Н

NOTES:

H = High voltage level

L = Low voltage level

LOGIC SYMBOL (IEEE/IEC)



74F08

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
V _{CC}	Supply voltage		-0.5 to +7.0	V
V _{IN}	Input voltage		-0.5 to +7.0	V
I _{IN}	Input current		-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state		–0.5 to V_{CC}	V
I _{OUT}	Current applied to output in Low output state		40	mA
-		Commercial range	0 to +70	°C
T _{amb}	Operating free-air temperature range	Industrial range	-40 to +85	°C
T _{stg}	Storage temperature range	-65 to +150	°C	

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER			LIMITS		UNIT
STMBOL	FARAMETER	FARAMETER				UNIT
V _{CC}	Supply voltage		4.5	5.0	5.5	V
V _{lh}	High-level input voltage		2.0			V
V _{IL}	Low-level input voltage			0.8	V	
I _{IK}	Input clamp current				-18	mA
I _{OH}	High-level output current				-1	mA
I _{OL}	Low-level output current				20	mA
T _{amb}	Operating free-air temperature range	Commercial range	0		+70	°C
'amb	operating nee-an temperature range	Industrial range	-40		+85	°C

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

CVMDO	DADAMETED		TEST CONDITIO	NC1		LIMITS		LINUT
SYMBOL	PARAMETER			MIN	TYP ²	MAX	UNIT	
Varia			$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}	2.5			V
V _{OH}	High-level output voltage		$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V
M			$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}		0.30	0.50	V
V _{OL}	Low-level output voltage		$V_{IH} = MIN, I_{OI} = MAX$	±5%V _{CC}		0.30	0.50	V
V _{IK}	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V
I _I	Input current at maximum voltage	n input	$V_{CC} = MAX, V_I = 7.0V$				100	μA
I _{IH}	High-level input current		$V_{CC} = MAX, V_1 = 2.7V$				20	μΑ
IIL	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA
I _{OS}	Short-circuit output current ³		V _{CC} = MAX		-60		-150	mA
1	Supply ourrent (total)	I _{CCH}	$V_{CC} = MAX$	V _{IN} = 4.5V		5.5	8.3	mA
Icc	Supply current (total)	I _{CCL}	V _{CC} = MAX	$V_{IN} = GND$		8.6	12.9	mA

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

^{2.} All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

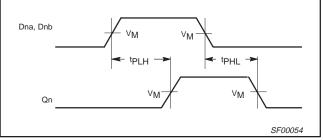
74F08

AC ELECTRICAL CHARACTERISTICS

			LIMITS							
SYMBOL	PARAMETER	TEST CONDITION	V.	$\begin{array}{l} {T_{amb}} = +25^{\circ}{C} \\ {V_{CC}} = +5.0{V} \\ {C_{L}} = 50pF, \\ {R_{L}} = 500\Omega \end{array}$		V _{CC} = +5. C _L =	C to +70°C 0V ± 10% 50pF, 500Ω	$T_{amb} = -40^{\circ}$ $V_{CC} = +5.$ $C_{L} = +5.$ $R_{L} = -5.$	UNIT	
			MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay Dna, Dnb to Qn	Waveform 1	3.0 2.5	4.2 4.0	5.6 5.3	3.0 2.5	6.6 6.3	2.5 2.5	6.6 6.3	ns

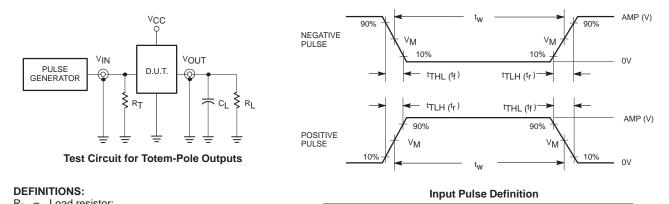
AC WAVEFORMS

For all waveforms, $V_M = 1.5V$.



Waveform 1. Propagation Delay for Non-Inverting Outputs

TEST CIRCUIT AND WAVEFORM



R_L = Load resistor;

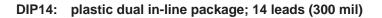
- see AC ELECTRICAL CHARACTERISTICS for value. C_L = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.
- $R_T =$ Termination resistance should be equal to Z_{OUT} of pulse generators.

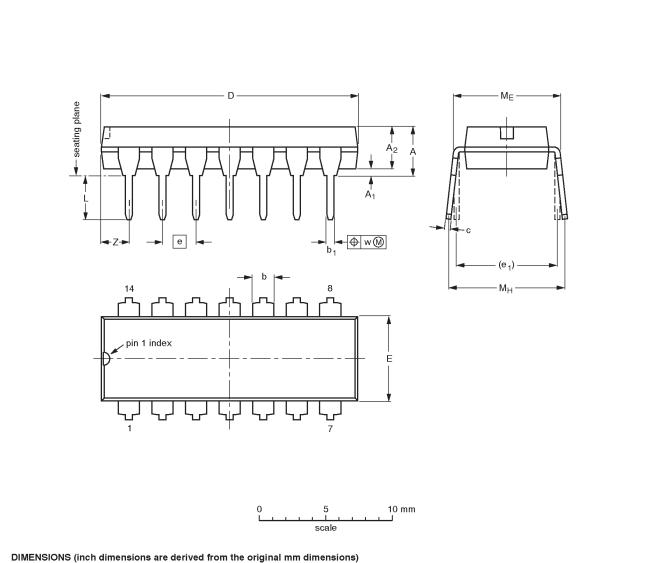
family	INPUT PULSE REQUIREMENTS							
Tanniy	amplitude	amplitude V _M rep. rate t _w		tw	t _{TLH}	t _{THL}		
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns		

SF00006

74F08

SOT27-1





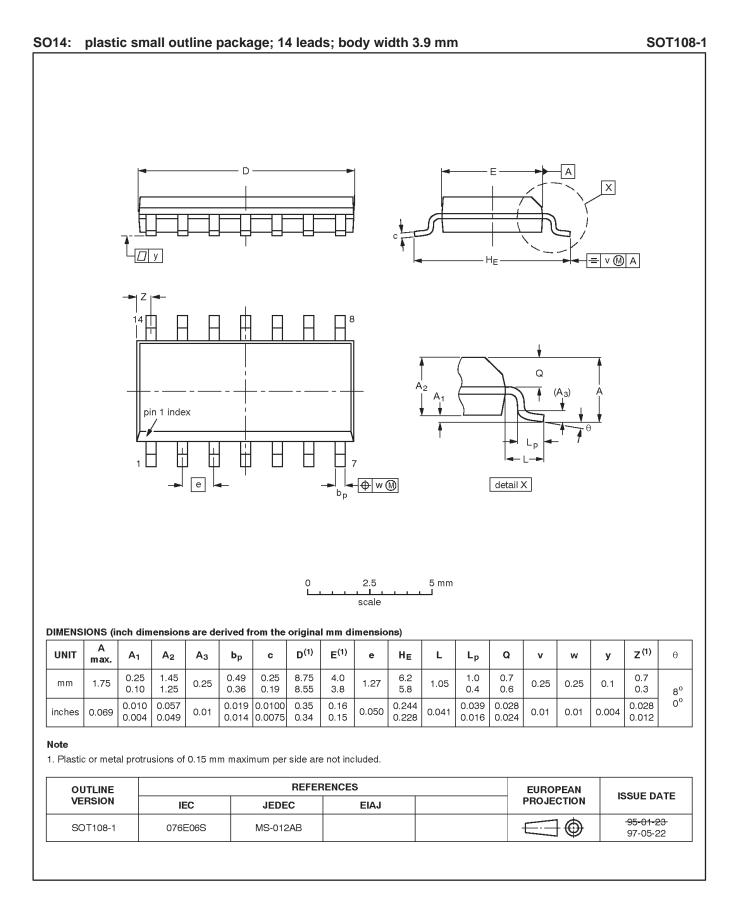
UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	с	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ	PROJECTION		ISSUE DATE	
SOT27-1	050G04	MO-001AA				-92-11-17 95-03-11	

74F08



74F08

NOTES

74F08

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

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